

Measurement Report for Device, P1 GSM850_GPRS 4TS_Right Cheek_Ch189

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HSL	CHEEK, 0.00	GSM 850	GSM, 10090-DAC	836.400, 189	9.7	0.943	43.2

Hardware Setup

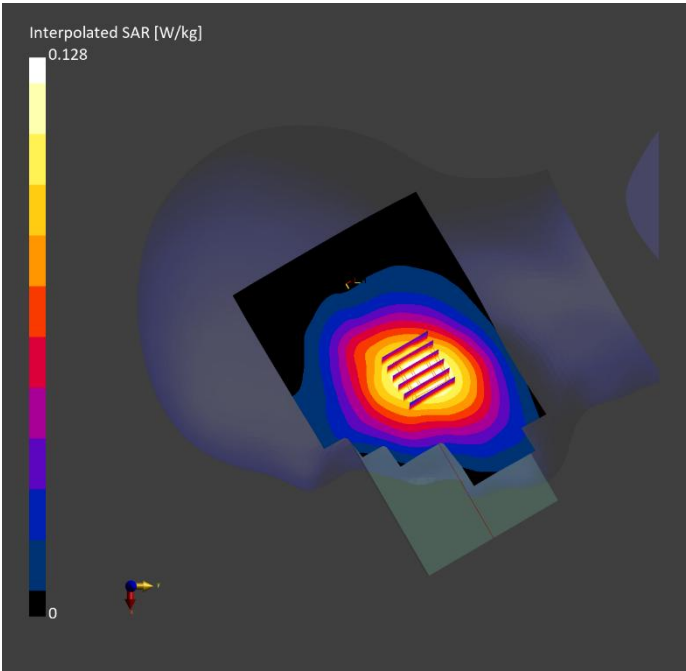
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-24	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-24	2025-02-24
psSAR1g [W/kg]	0.110	0.112
psSAR10g [W/kg]	0.075	0.090
Power Drift [dB]	0.13	-0.07
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		97.7
Dist 3dB Peak [mm]		> 15.0



Measurement Report for Device, P2 GSM1900_GPRS 4TS_Left Cheek_Ch 661

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HSL	CHEEK, 0.00	PCS 1900	GSM, 10090-DAC	1880.000, 661	7.77	1.44	39.9

Hardware Setup

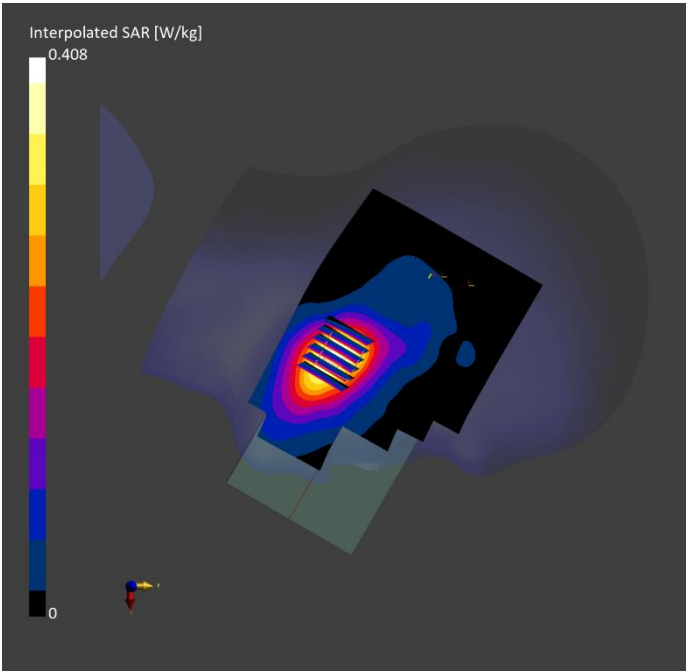
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-25	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-25	2025-02-25
psSAR1g [W/kg]	0.266	0.284
psSAR10g [W/kg]	0.158	0.186
Power Drift [dB]	-0.11	0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		90.0
Dist 3dB Peak [mm]		15.3



Measurement Report for Device, P3 WCDMA II_RMC12.2K_Left Cheek_Ch 9262

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HSL	CHEEK, 0.00	Band 2	WCDMA, 10011-CAC	1852.400, 9262	7.77	1.42	40.0

Hardware Setup

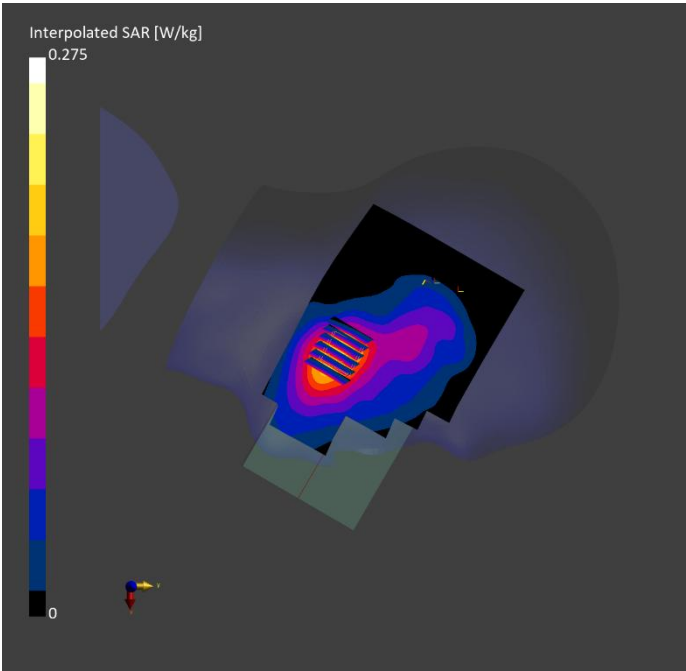
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-25	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-25	2025-02-25
psSAR1g [W/kg]	0.187	0.198
psSAR10g [W/kg]	0.112	0.133
Power Drift [dB]	-0.03	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		91.1
Dist 3dB Peak [mm]		14.8



Measurement Report for Device, P4 WCDMA IV_RMC12.2K_Left Cheek_Ch 1312

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HSL	CHEEK, 0.00	Band 4	WCDMA, 10011-CAC	1712.400, 1312	8.01	1.35	40.2

Hardware Setup

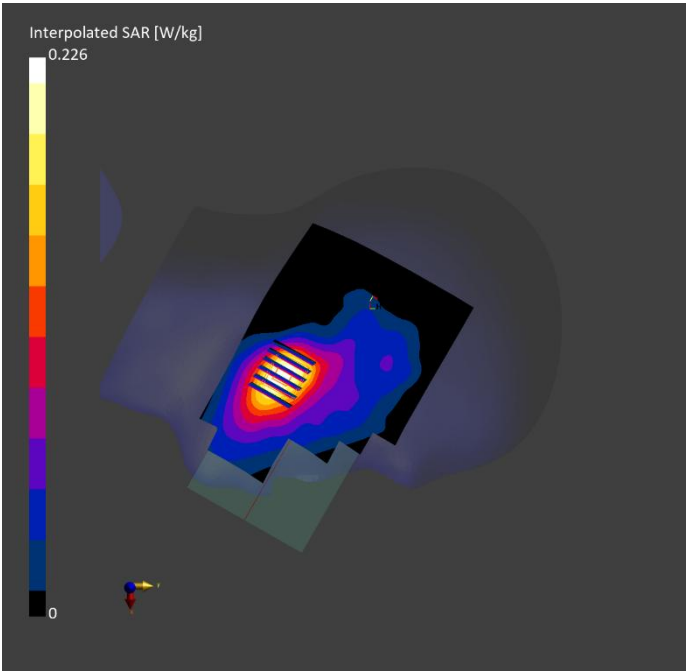
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-26	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-26	2025-02-26
psSAR1g [W/kg]	0.146	0.158
psSAR10g [W/kg]	0.088	0.104
Power Drift [dB]	0.19	-0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		89.5
Dist 3dB Peak [mm]		13.6



Measurement Report for Device, P5 WCDMA V_RMC12.2K_Left Cheek_Ch 4132

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HSL	CHEEK, 0.00	Band 5	WCDMA, 10011-CAC	826,400, 4132	9.7	0.939	43.2

Hardware Setup

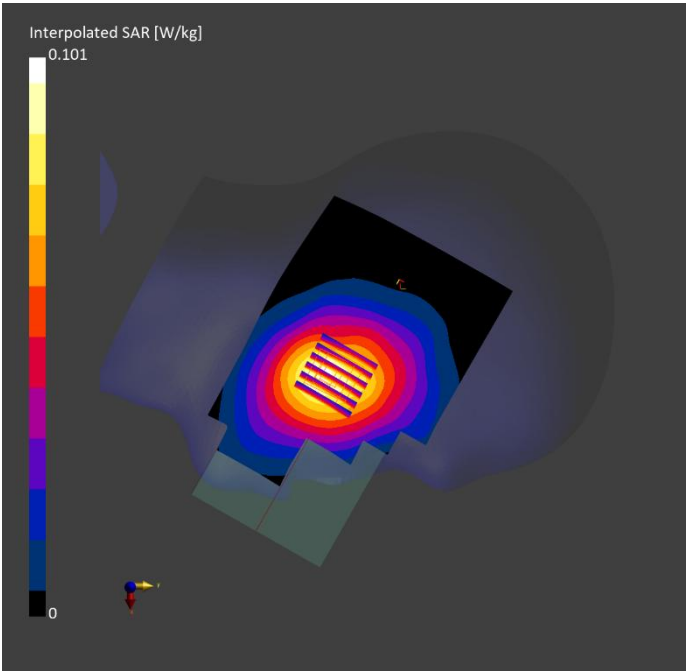
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-24	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-24	2025-02-24
psSAR1g [W/kg]	0.081	0.084
psSAR10g [W/kg]	0.056	0.068
Power Drift [dB]	-0.08	0.04
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		94.4
Dist 3dB Peak [mm]		> 15.0



Measurement Report for Device, P6 LTE 2_QPSK20M_Left Cheek_Ch 18700_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HSL	CHEEK, 0.00	Band 2	LTE-FDD, 10169-CAF	1860.000, 18700	7.77	1.43	39.9

Hardware Setup

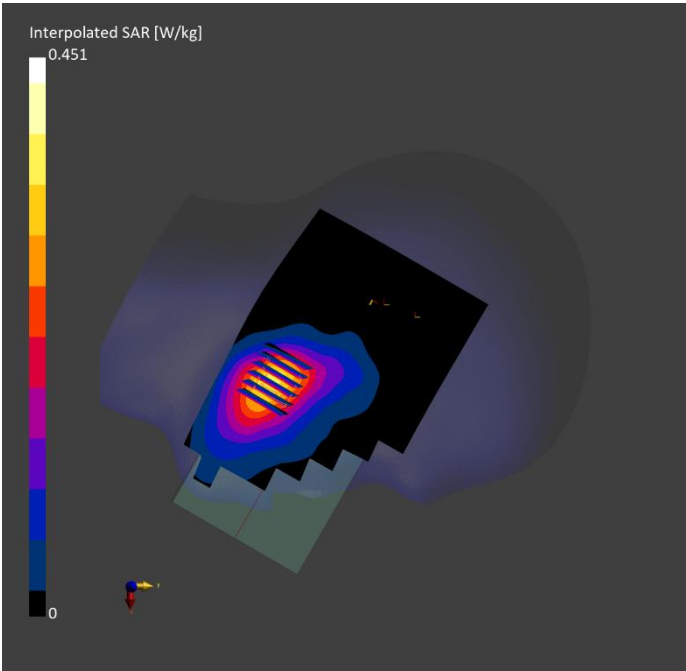
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-25	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-25	2025-02-25
psSAR1g [W/kg]	0.309	0.324
psSAR10g [W/kg]	0.179	0.216
Power Drift [dB]	-0.07	0.03
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		91.2
Dist 3dB Peak [mm]		14.9



Measurement Report for Device, P7 LTE 4_QPSK20M_Left Cheek_Ch 20050_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HSL	CHEEK, 0.00	Band 4	LTE-FDD, 10169-CAF	1720.000, 20050	8.01	1.36	40.2

Hardware Setup

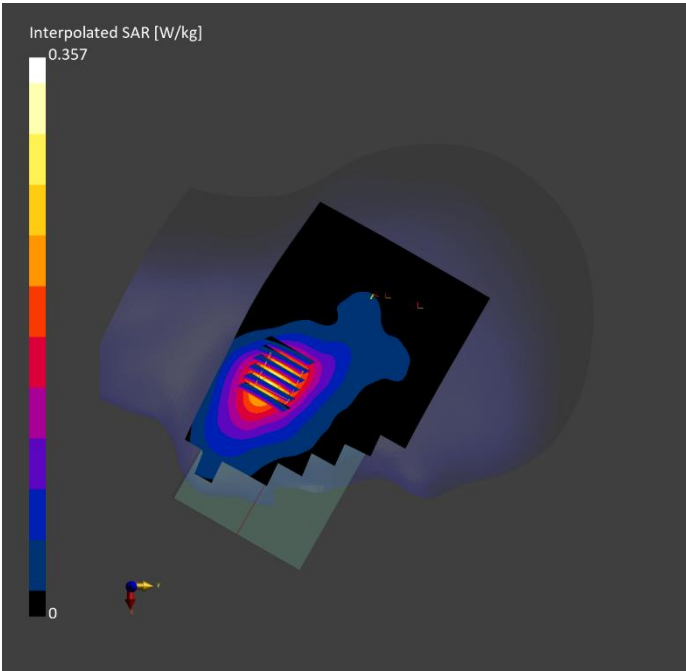
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-26	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-26	2025-02-26
psSAR1g [W/kg]	0.246	0.259
psSAR10g [W/kg]	0.144	0.173
Power Drift [dB]	-0.04	0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		90.4
Dist 3dB Peak [mm]		13.7



Measurement Report for Device, P8 LTE 5_QPSK10M_Left Cheek_Ch 20525_1RB_OS24

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HSL	CHEEK, 0.00	Band 5	LTE-FDD, 10175-CAH	836.500, 20525	9.7	0.943	43.2

Hardware Setup

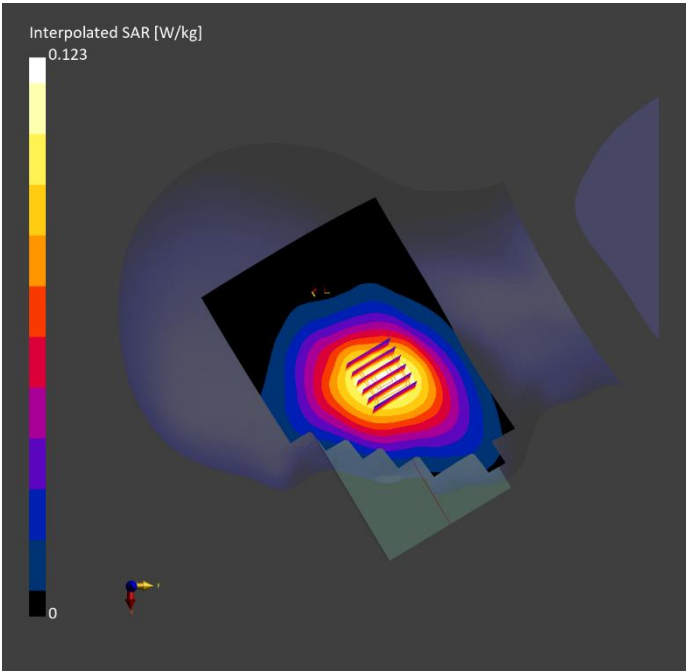
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-24	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-24	2025-02-24
psSAR1g [W/kg]	0.104	0.109
psSAR10g [W/kg]	0.072	0.087
Power Drift [dB]	-0.04	-0.03
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		98.8
Dist 3dB Peak [mm]		> 15.0



Measurement Report for Device, P9 LTE 12&17_QPSK10M_Left Cheek_Ch 23130_1RB_OS24

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HSL	CHEEK, 0.00	Band 12	LTE-FDD, 10175-CAH	711.000, 23130	9.99	0.904	43.0

Hardware Setup

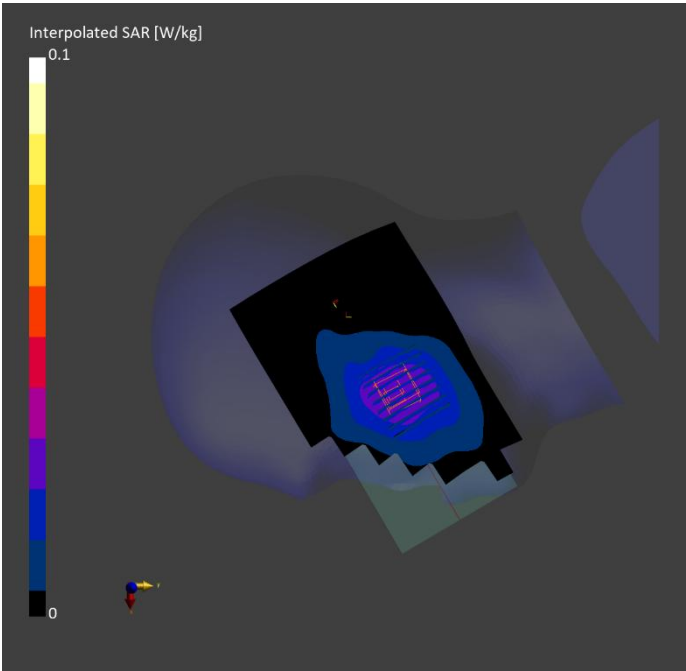
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-27	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-27	2025-02-27
psSAR1g [W/kg]	0.029	0.029
psSAR10g [W/kg]	0.020	0.025
Power Drift [dB]	-0.03	0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		93.7
Dist 3dB Peak [mm]		27.0



Measurement Report for Device, P10 LTE 41_QPSK20M_Left Cheek_Ch 41040_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HSL	CHEEK, 0.00	Band 41	LTE-TDD, 10172-CAH	2635.000, 41040	7.29	1.97	39.3

Hardware Setup

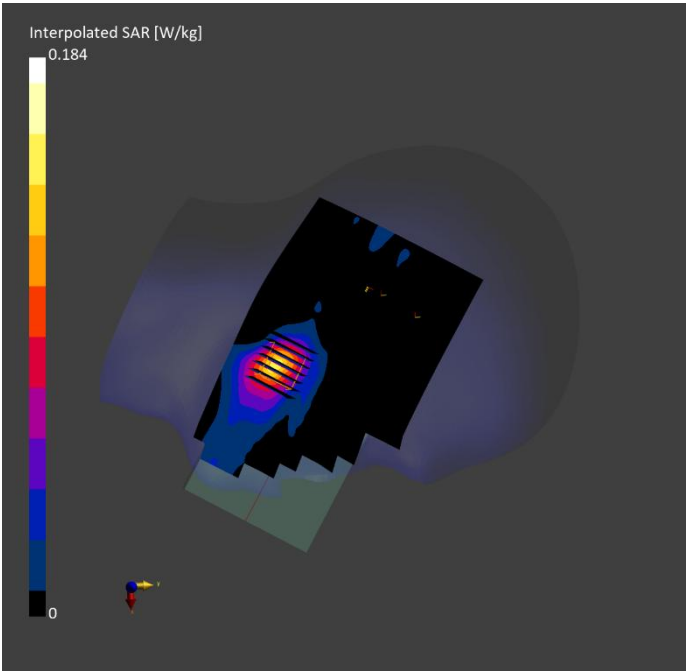
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-27	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 220.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-27	2025-02-27
psSAR1g [W/kg]	0.113	0.108
psSAR10g [W/kg]	0.056	0.056
Power Drift [dB]	-0.02	-0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		85.5
Dist 3dB Peak [mm]		10.3



Measurement Report for Device, P11 LTE 66_QPSK20M_Left Cheek_Ch 132072_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HSL	CHEEK, 0.00	Band 66	LTE-FDD, 10169-CAF	1720.000, 132072	8.01	1.36	40.2

Hardware Setup

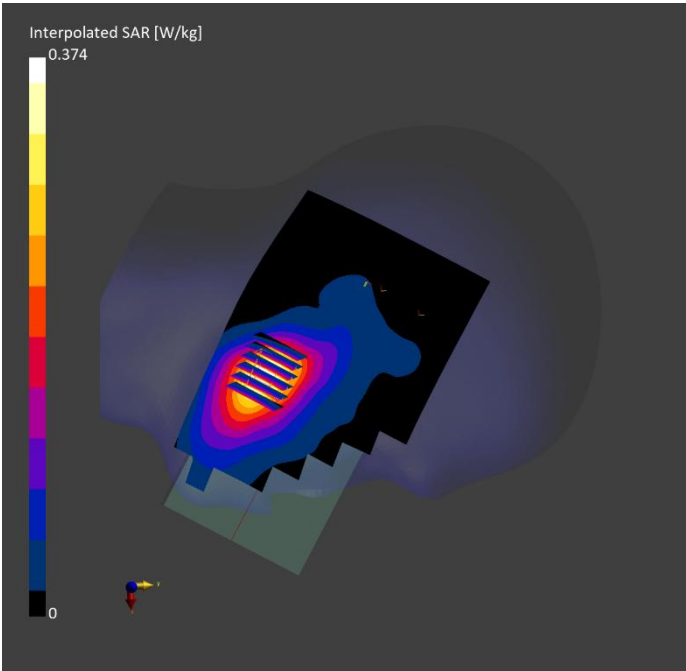
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-26	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-26	2025-02-26
psSAR1g [W/kg]	0.258	0.272
psSAR10g [W/kg]	0.151	0.182
Power Drift [dB]	-0.02	0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		91.5
Dist 3dB Peak [mm]		13.9



Measurement Report for Device, P12 LTE 71_QPSK20M_Right Cheek_Ch 133222_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
RightHead, HSL	CHEEK, 0.00	Band 71	LTE-FDD, 10169-CAF	673.000, 133222	9.99	0.891	43.1

Hardware Setup

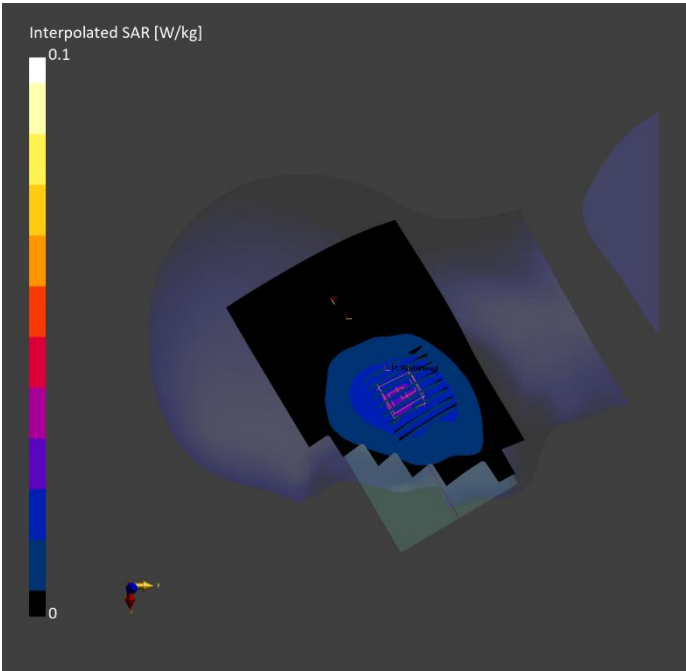
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-27	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-27	2025-02-27
psSAR1g [W/kg]	0.024	0.023
psSAR10g [W/kg]	0.017	0.020
Power Drift [dB]	-0.05	0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		98.6
Dist 3dB Peak [mm]		17.8



Measurement Report for Device, P13 802.11b_Left Cheek_Ch 6

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HSL	CHEEK, 0.00	WLAN 2.4GHz	WLAN, 10415-AAA	2437.000, 6	7.25	1.82	39.6

Hardware Setup

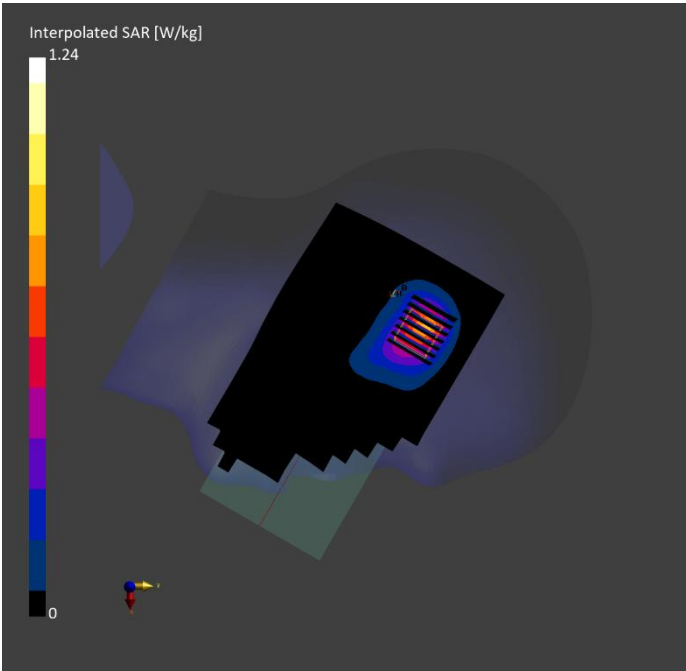
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-28	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 220.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-28	2025-02-28
psSAR1g [W/kg]	0.665	0.709
psSAR10g [W/kg]	0.335	0.358
Power Drift [dB]	0.08	0.08
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		85.7
Dist 3dB Peak [mm]		12.1



Measurement Report for Device, P14 802.11a_Left Cheek_Ch 48

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HSL	CHEEK, 0.00	U-NII-1, U-NII-2A	WLAN, 10417-AAD	5240.000, 48	5.45	4.62	37.1

Hardware Setup

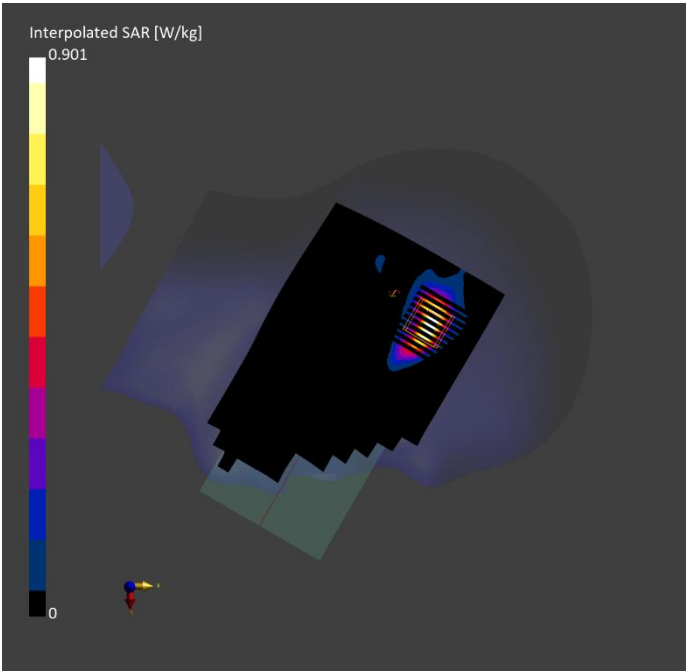
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-28	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 220.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-28	2025-02-28
psSAR1g [W/kg]	0.231	0.241
psSAR10g [W/kg]	0.084	0.072
Power Drift [dB]	-0.01	0.06
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		64.6
Dist 3dB Peak [mm]		6.5



Measurement Report for Device, P15 802.11a_Left Cheek_Ch 157

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HSL	CHEEK, 0.00	U-NII-2C, U-NII-3	WLAN, 10317-AAE	5785.000, 157	4.98	5.22	36.1

Hardware Setup

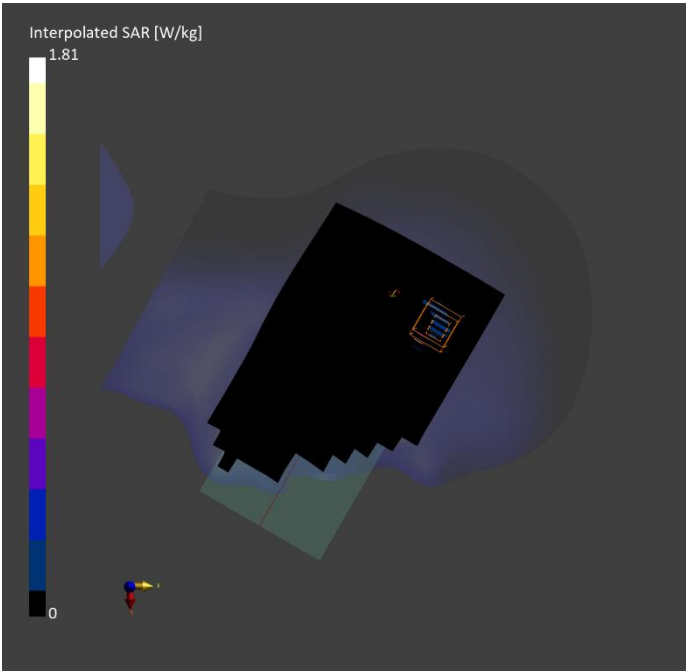
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-28	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 220.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-28	2025-02-28
psSAR1g [W/kg]	0.148	0.149
psSAR10g [W/kg]	0.051	0.040
Power Drift [dB]	-0.04	0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		55.9
Dist 3dB Peak [mm]		7.7



Measurement Report for Device, P16 BT_1 DH5_Left Cheek_Ch 78

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
LeftHead, HSL	CHEEK, 0.00	ISM 2.4 GHz Band	Bluetooth, 10032-CAA	2480.000, 78	7.25	1.86	39.5

Hardware Setup

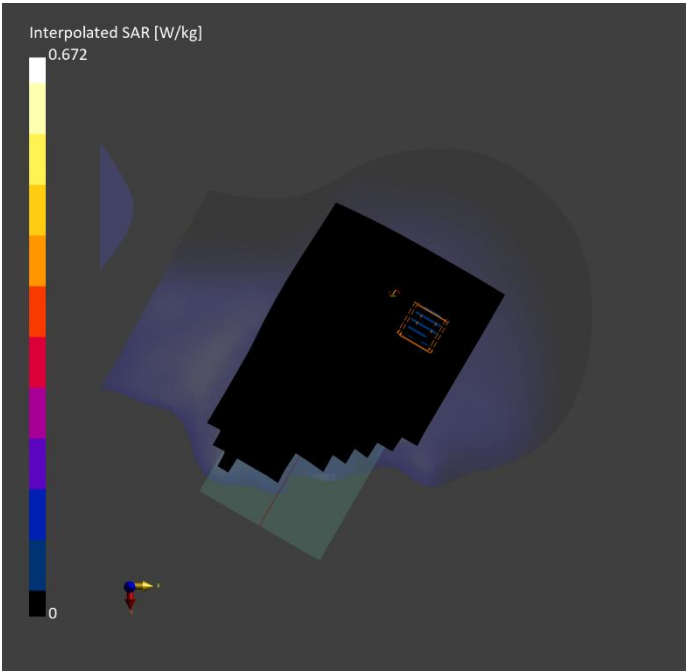
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-28	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 220.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	All points
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-28	2025-02-28
psSAR1g [W/kg]	0.064	0.064
psSAR10g [W/kg]	0.031	0.029
Power Drift [dB]	0.11	-0.04
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		84.6
Dist 3dB Peak [mm]		11.1



Measurement Report for Device, P17 GSM850_GPRS 4TS_Rear Face_1cm_Ch 189

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	GSM 850	GSM, 10090-DAC	836.400, 189	9.7	0.948	42.6

Hardware Setup

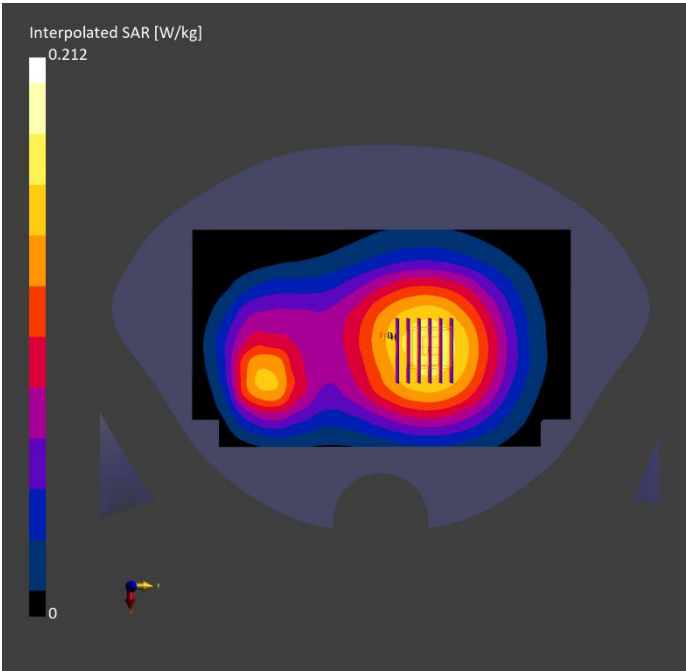
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-24	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-24	2025-02-24
psSAR1g [W/kg]	0.152	0.158
psSAR10g [W/kg]	0.107	0.123
Power Drift [dB]	-0.05	-0.05
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		91.3
Dist 3dB Peak [mm]		> 15.0



Measurement Report for Device, P18 GSM1900_GPRS 4TS_Rear Face_1cm_Ch 661

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	PCS 1900	GSM, 10090-DAC	1880.000, 661	7.77	1.44	39.9

Hardware Setup

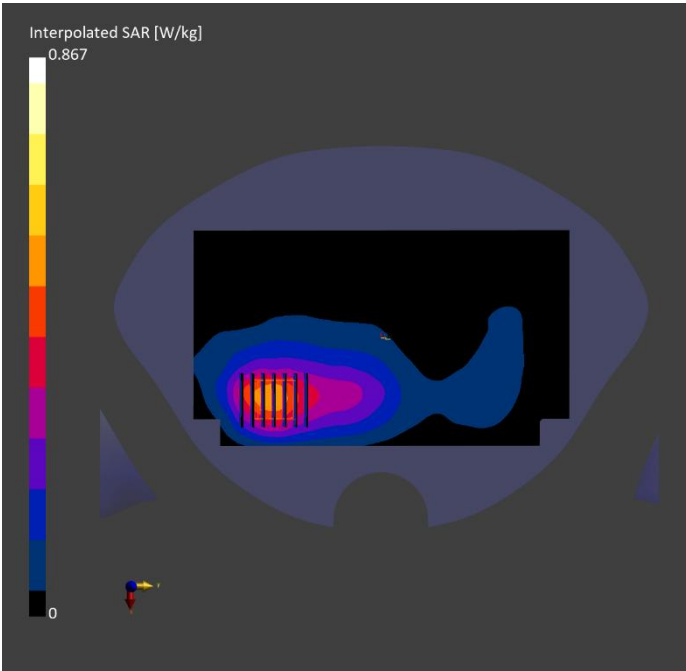
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-25	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-25	2025-02-25
psSAR1g [W/kg]	0.481	0.528
psSAR10g [W/kg]	0.280	0.310
Power Drift [dB]	0.09	0.10
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		87.3
Dist 3dB Peak [mm]		14.5



Measurement Report for Device, P19 WCDMA II_RMC12.2K_Rear Face_1cm_Ch 9262

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 2	WCDMA, 10011-CAC	1852.400, 9262	7.77	1.42	40.0

Hardware Setup

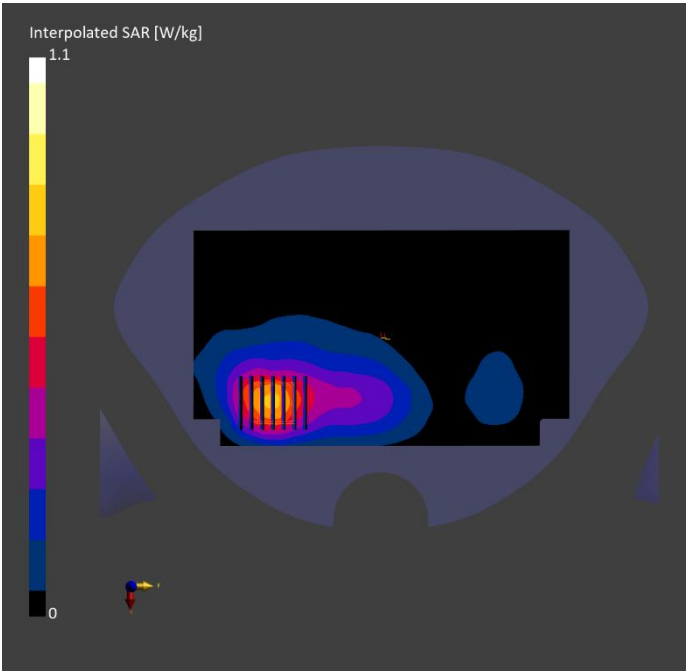
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-25	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-25	2025-02-25
psSAR1g [W/kg]	0.638	0.687
psSAR10g [W/kg]	0.376	0.406
Power Drift [dB]	0.10	-0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		88.1
Dist 3dB Peak [mm]		14.5



Measurement Report for Device, P20 WCDMA IV_RMC12.2K_Rear Face_1cm_Ch 1312

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 4	WCDMA, 10011-CAC	1712.400, 1312	8.01	1.35	40.2

Hardware Setup

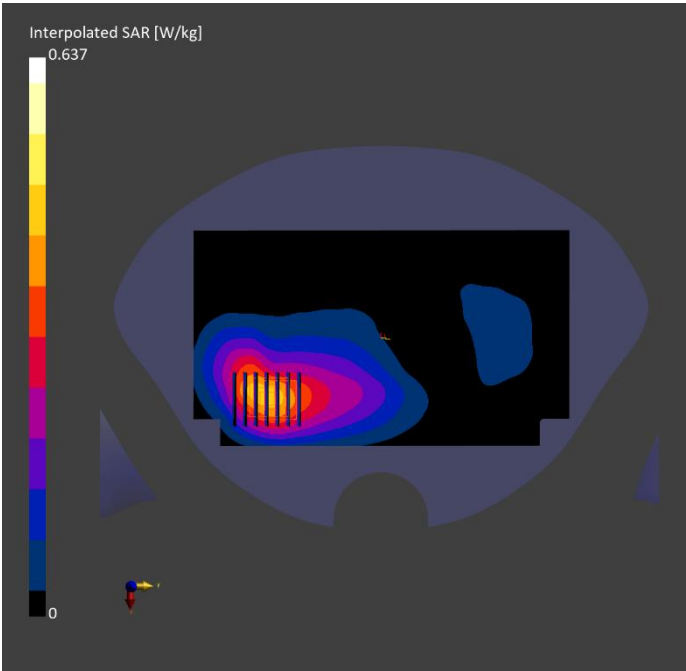
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-26	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-26	2025-02-26
psSAR1g [W/kg]	0.386	0.396
psSAR10g [W/kg]	0.235	0.245
Power Drift [dB]	0.02	0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		85.3
Dist 3dB Peak [mm]		14.7



Measurement Report for Device, P21 WCDMA V_RMC12.2K_Rear Face_1cm_Ch 4132

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 5	WCDMA, 10011-CAC	826,400, 4132	9.7	0.944	42.6

Hardware Setup

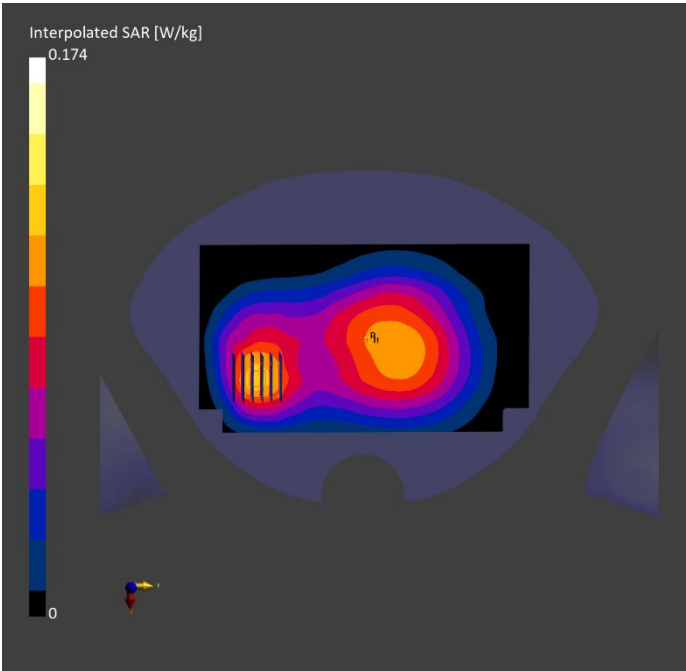
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-24	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-24	2025-02-24
psSAR1g [W/kg]	0.111	0.110
psSAR10g [W/kg]	0.074	0.071
Power Drift [dB]	0.20	-0.09
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		86.6
Dist 3dB Peak [mm]		21.4



Measurement Report for Device, P22 LTE 2_QPSK20M_Rear Face_1cm_Ch 18700_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 2	LTE-FDD, 10169-CAF	1860.000, 18700	7.77	1.43	39.9

Hardware Setup

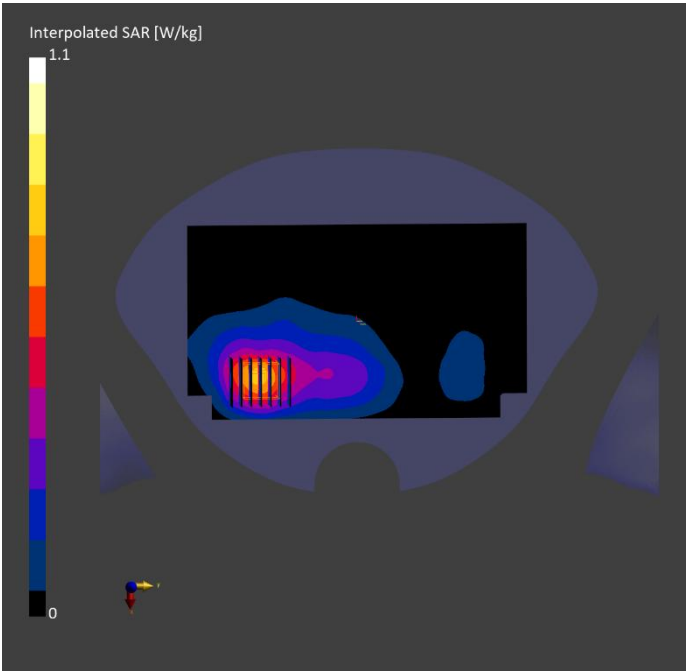
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-25	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-25	2025-02-25
psSAR1g [W/kg]	0.646	0.661
psSAR10g [W/kg]	0.377	0.388
Power Drift [dB]	-0.05	-0.05
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		84.6
Dist 3dB Peak [mm]		14.7



Measurement Report for Device, P23 LTE 4_QPSK20M_Rear Face_1cm_Ch 20050_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 4	LTE-FDD, 10169-CAF	1720.000, 20050	8.01	1.36	40.2

Hardware Setup

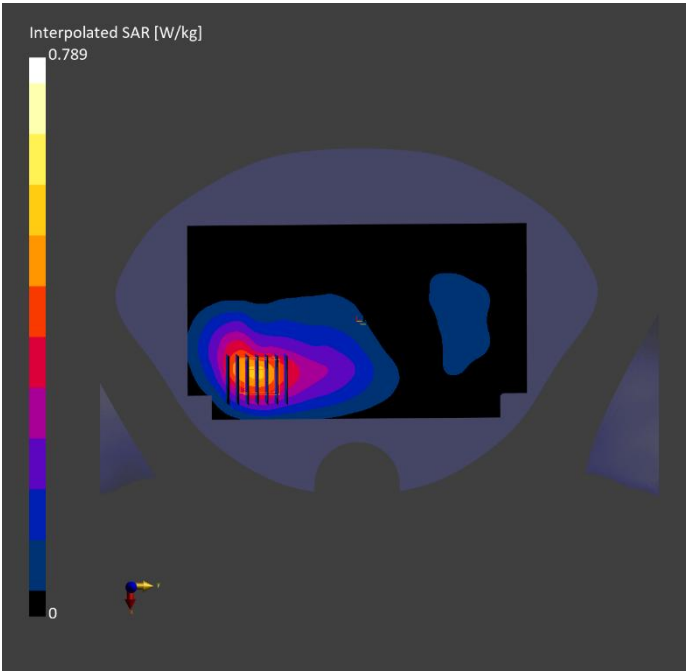
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-26	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-26	2025-02-26
psSAR1g [W/kg]	0.461	0.470
psSAR10g [W/kg]	0.275	0.286
Power Drift [dB]	0.02	-0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		83.7
Dist 3dB Peak [mm]		14.5



Measurement Report for Device, P24 LTE 5_QPSK10M_Rear Face_1cm_Ch 20525_1RB_OS24

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 5	LTE-FDD, 10175-CAH	836.500, 20525	9.7	0.943	43.2

Hardware Setup

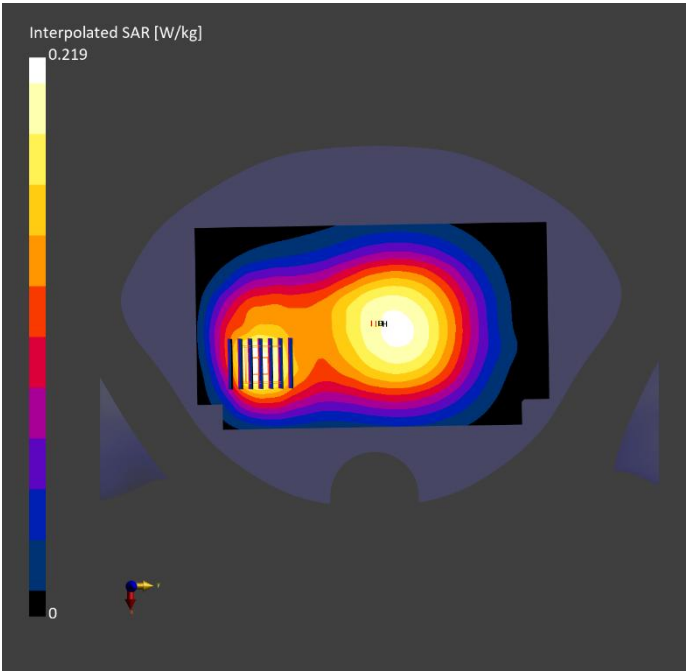
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-24	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-24	2025-02-24
psSAR1g [W/kg]	0.144	0.141
psSAR10g [W/kg]	0.097	0.091
Power Drift [dB]	-0.00	-0.03
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		88.5
Dist 3dB Peak [mm]		18.3



Measurement Report for Device, P25 LTE 12&17_QPSK10M_Rear Face_1cm_Ch 23130_1RB_OS24

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 12	LTE-FDD, 10175-CAH	711.000, 23130	9.99	0.904	43.0

Hardware Setup

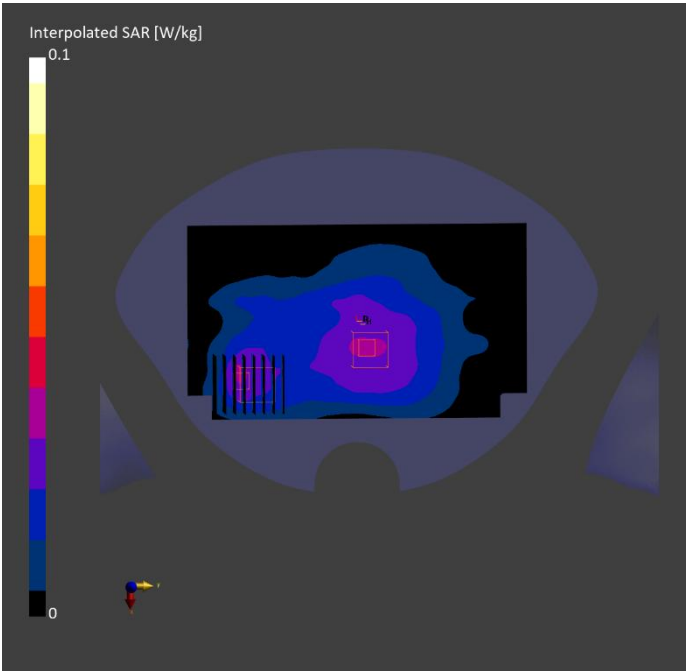
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-27	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-27	2025-02-27
psSAR1g [W/kg]	0.031	0.029
psSAR10g [W/kg]	0.021	0.016
Power Drift [dB]	-0.08	-0.07
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		78.2
Dist 3dB Peak [mm]		10.3



Measurement Report for Device, P26 LTE 41_QPSK20M_Rear Face_1cm_Ch 41040_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 41	LTE-TDD, 10172-CAH	2635.000, 41040	7.29	1.97	39.3

Hardware Setup

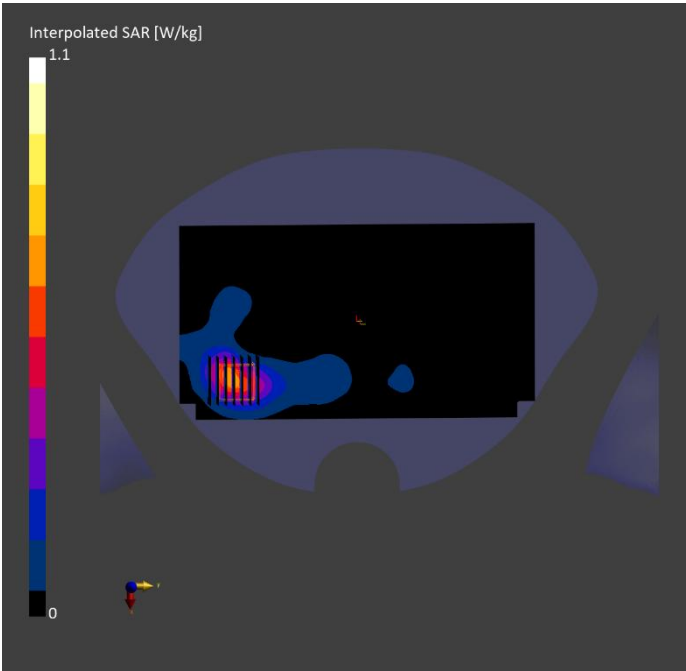
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-27	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 220.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-27	2025-02-27
psSAR1g [W/kg]	0.565	0.589
psSAR10g [W/kg]	0.272	0.289
Power Drift [dB]	-0.02	-0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		82.6
Dist 3dB Peak [mm]		10.0



Measurement Report for Device, P27 LTE 66_QPSK20M_Rear Face_1cm_Ch 132072_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 66	LTE-FDD, 10169-CAF	1720.000, 132072	8.01	1.36	40.2

Hardware Setup

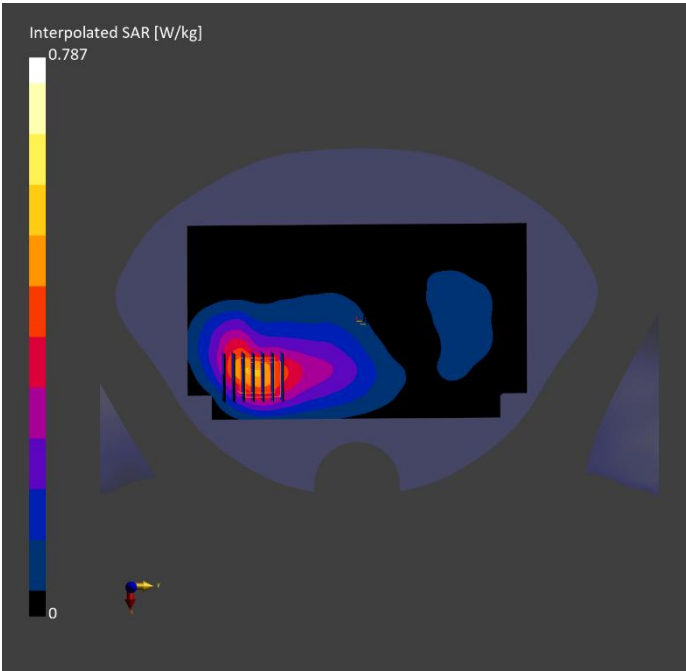
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-26	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-26	2025-02-26
psSAR1g [W/kg]	0.452	0.471
psSAR10g [W/kg]	0.271	0.288
Power Drift [dB]	-0.07	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		84.9
Dist 3dB Peak [mm]		13.5



Measurement Report for Device, P28 LTE 71_QPSK20M_Rear Face_1cm_Ch 133222_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 71	LTE-FDD, 10169-CAF	673.000, 133222	9.99	0.891	43.1

Hardware Setup

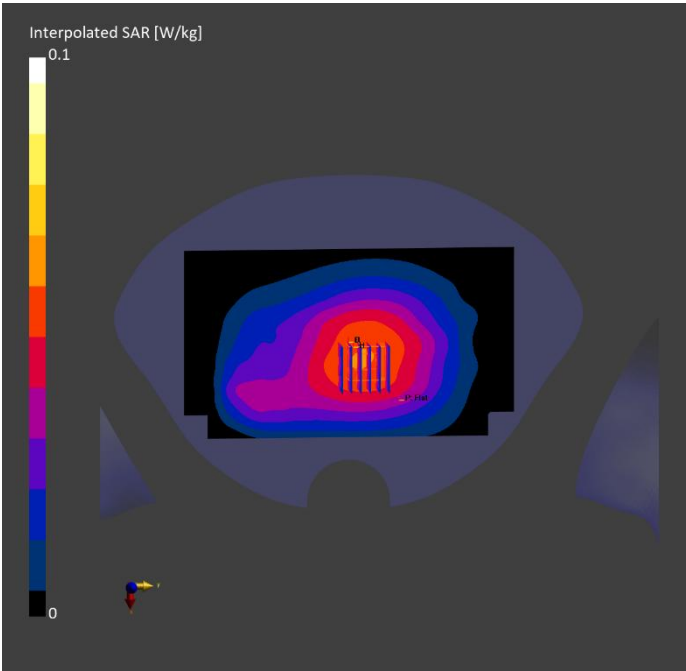
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-27	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-27	2025-02-27
psSAR1g [W/kg]	0.052	0.054
psSAR10g [W/kg]	0.038	0.044
Power Drift [dB]	-0.01	-0.05
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		97.2
Dist 3dB Peak [mm]		> 15.0



Measurement Report for Device, P29 802.11b_Rear Face_1cm_Ch 6

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	WLAN 2.4GHz	WLAN, 10415-AAA	2437.000, 6	7.25	1.82	39.6

Hardware Setup

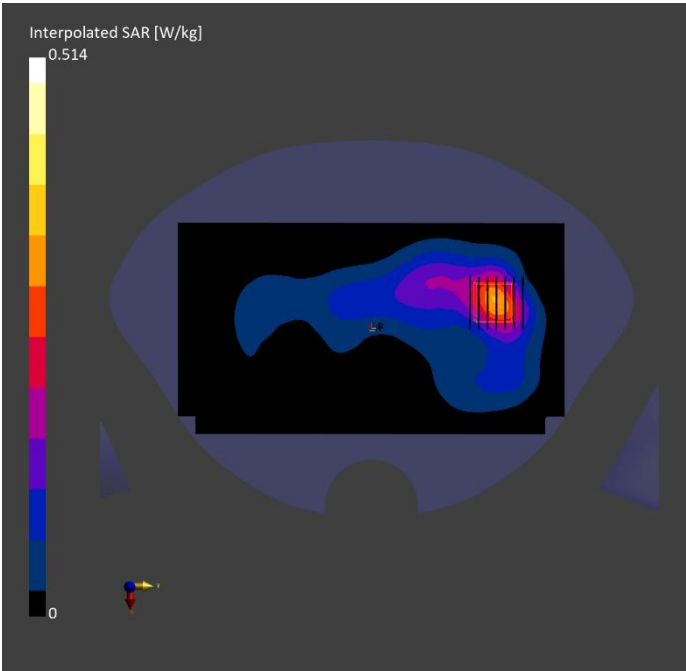
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-28	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 220.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-28	2025-02-28
psSAR1g [W/kg]	0.278	0.278
psSAR10g [W/kg]	0.144	0.143
Power Drift [dB]	0.05	-0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		81.9
Dist 3dB Peak [mm]		12.1



Measurement Report for Device, P30 802.11a_Rear Face_1cm_Ch 48

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	U-NII-1, U-NII-2A	WLAN, 10417-AAD	5240.000, 48	5.45	4.62	37.1

Hardware Setup

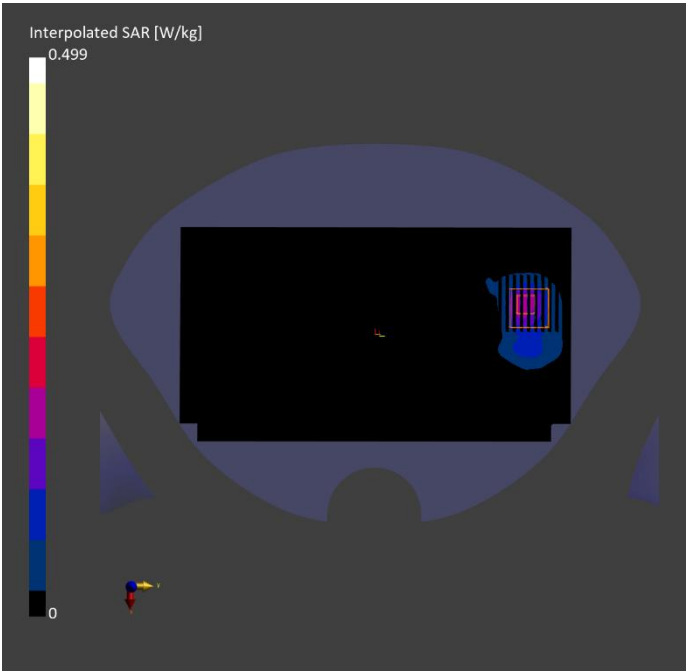
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-28	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 220.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-28	2025-02-28
psSAR1g [W/kg]	0.147	0.140
psSAR10g [W/kg]	0.055	0.044
Power Drift [dB]	0.00	-0.05
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		68.4
Dist 3dB Peak [mm]		7.9



Measurement Report for Device, P31 802.11a_Rear Face_1cm_Ch 157

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	U-NII-2C, U-NII-3	WLAN, 10317-AAE	5785.000, 157	4.98	5.22	36.1

Hardware Setup

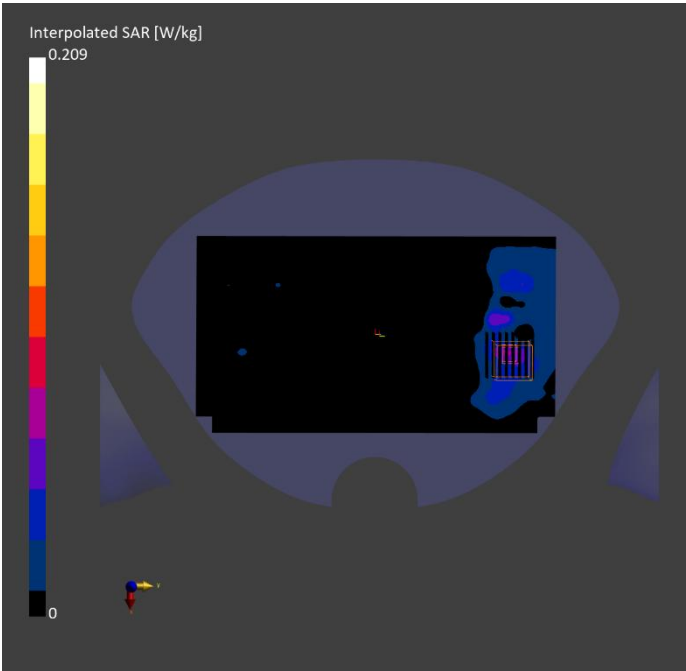
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-28	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 220.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-28	2025-02-28
psSAR1g [W/kg]	0.051	0.029
psSAR10g [W/kg]	0.019	0.008
Power Drift [dB]	-0.03	-0.04
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		66.7
Dist 3dB Peak [mm]		4.8



Measurement Report for Device, P32 BT_Rear Face_1cm_Ch 78

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	ISM 2.4 GHz Band	Bluetooth, 10032-CAA	2480.000, 78	7.25	1.86	39.5

Hardware Setup

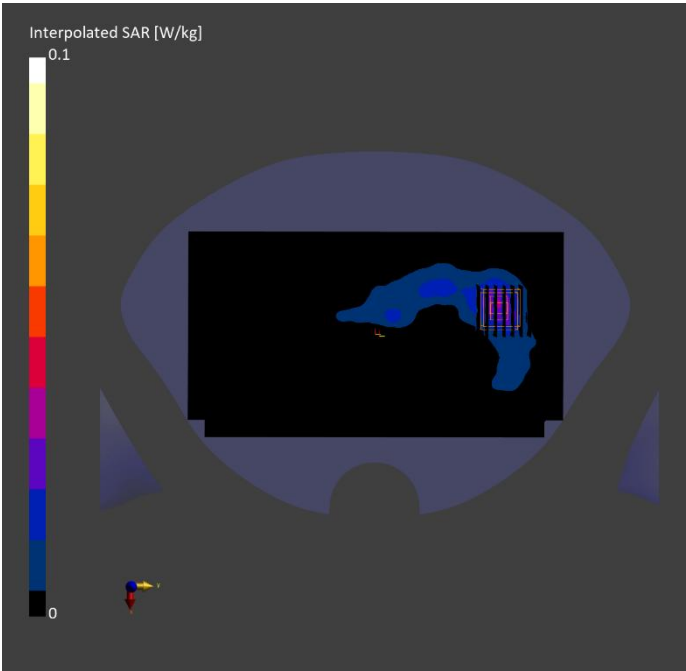
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-28	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 220.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-28	2025-02-28
psSAR1g [W/kg]	0.027	0.028
psSAR10g [W/kg]	0.014	0.013
Power Drift [dB]	0.06	-0.03
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		76.5
Dist 3dB Peak [mm]		10.1



Measurement Report for Device, P33 GSM850_GPRS 4TS_Rear Face_1cm_Ch 189

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	GSM 850	GSM, 10090-DAC	836.400, 189	9.7	0.943	43.2

Hardware Setup

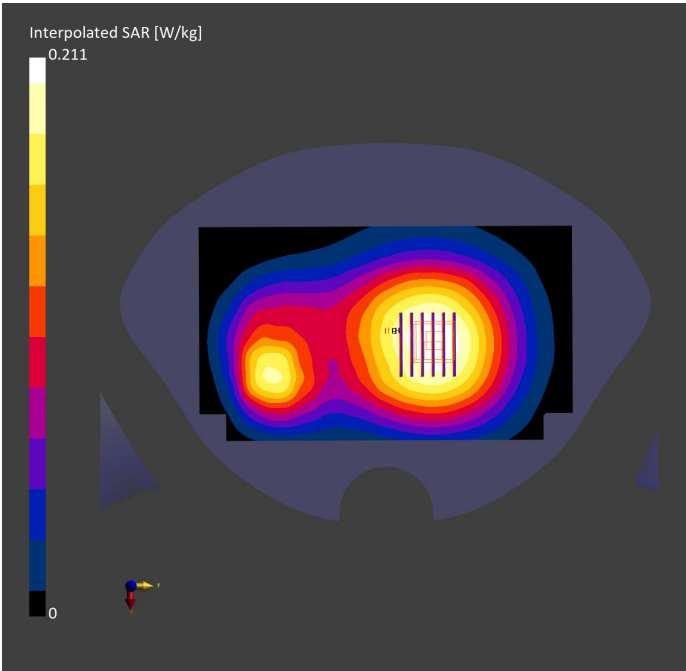
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-24	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-24	2025-02-24
psSAR1g [W/kg]	0.151	0.157
psSAR10g [W/kg]	0.106	0.122
Power Drift [dB]	-0.05	-0.05
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		91.3
Dist 3dB Peak [mm]		> 15.0



Measurement Report for Device, P34 GSM1900_GPRS 4TS_Rear Face_1cm_Ch 661

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	PCS 1900	GSM, 10090-DAC	1880.000, 661	7.77	1.44	39.9

Hardware Setup

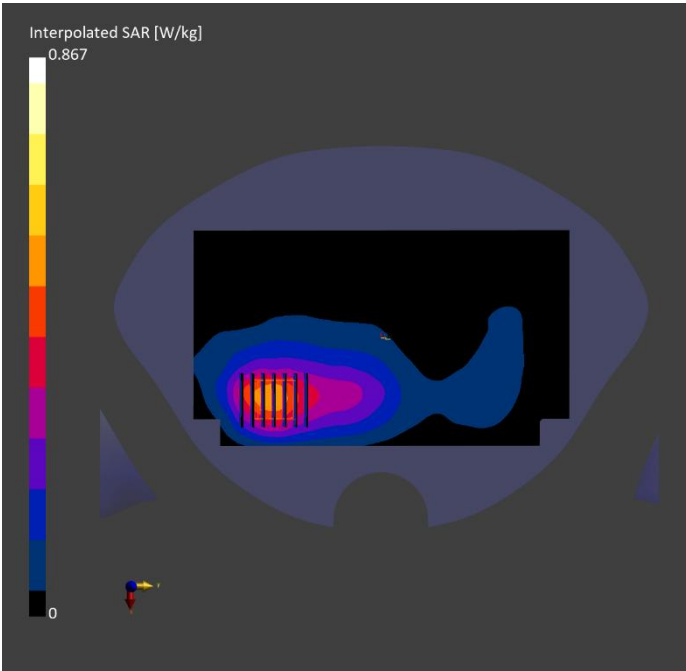
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-25	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-25	2025-02-25
psSAR1g [W/kg]	0.481	0.528
psSAR10g [W/kg]	0.280	0.310
Power Drift [dB]	0.09	0.10
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		87.3
Dist 3dB Peak [mm]		14.5



Measurement Report for Device, P35 WCDMA II_RMC12.2K_Rear Face_1cm_Ch 9262

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 2	WCDMA, 10011-CAC	1852.400, 9262	7.77	1.42	40.0

Hardware Setup

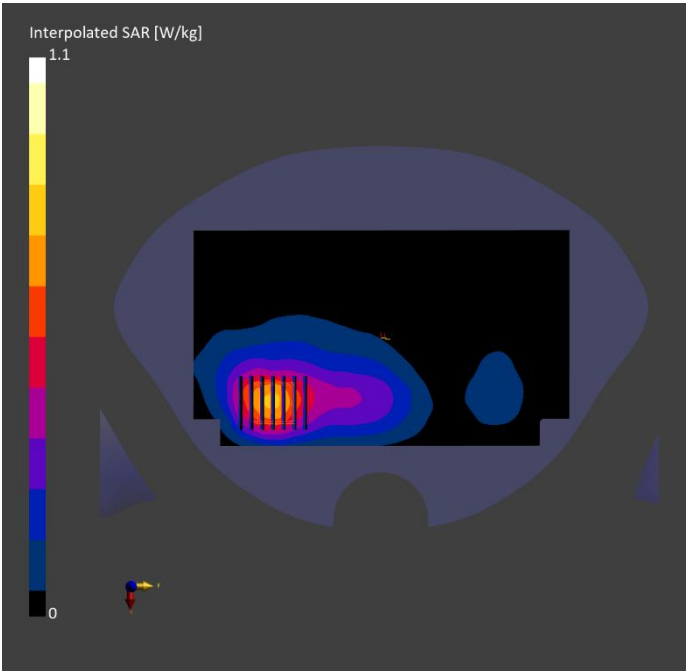
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-25	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-25	2025-02-25
psSAR1g [W/kg]	0.638	0.687
psSAR10g [W/kg]	0.376	0.406
Power Drift [dB]	0.10	-0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		88.1
Dist 3dB Peak [mm]		14.5



Measurement Report for Device, P36 WCDMA IV_RMC12.2K_Rear Face_1cm_Ch 1312

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 4	WCDMA, 10011-CAC	1712.400, 1312	8.01	1.35	40.2

Hardware Setup

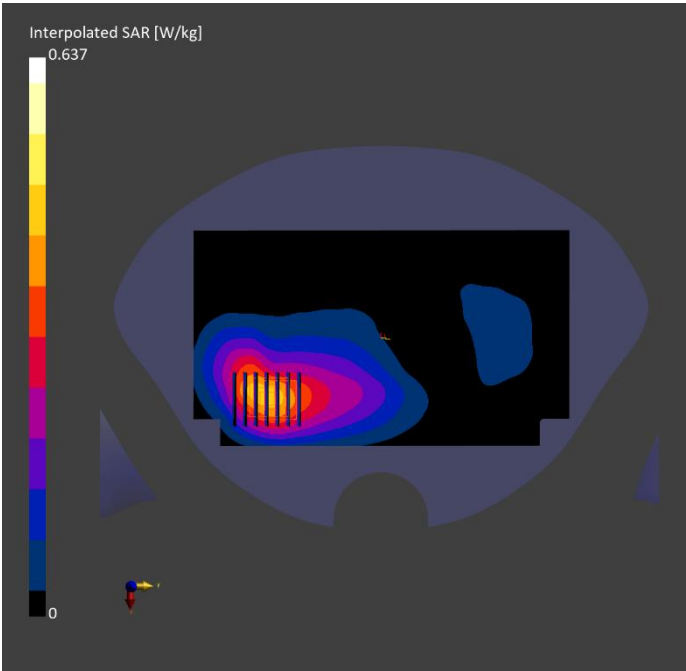
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-26	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-26	2025-02-26
psSAR1g [W/kg]	0.386	0.396
psSAR10g [W/kg]	0.235	0.245
Power Drift [dB]	0.02	0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		85.3
Dist 3dB Peak [mm]		14.7



Measurement Report for Device, P37 WCDMA V_RMC12.2K_Rear Face_1cm_Ch 4132

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 5	WCDMA, 10011-CAC	826,400, 4132	9.7	0.939	43.2

Hardware Setup

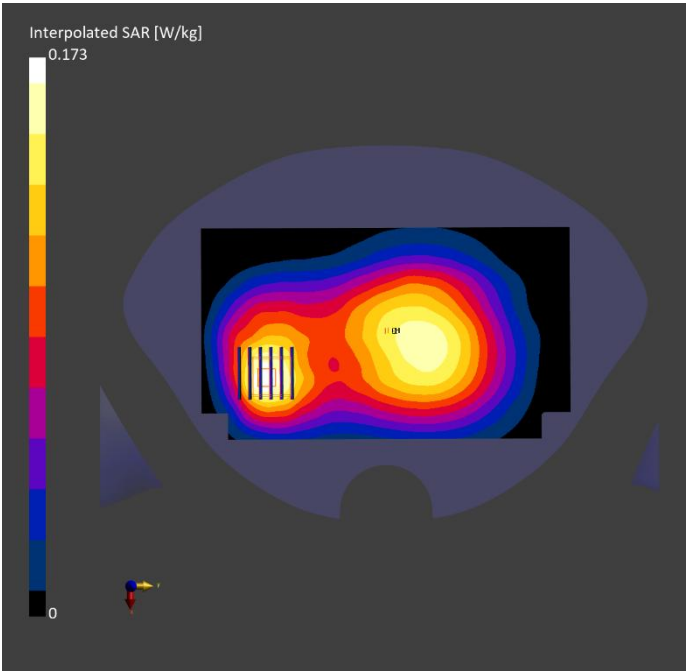
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-24	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-24	2025-02-24
psSAR1g [W/kg]	0.111	0.109
psSAR10g [W/kg]	0.074	0.070
Power Drift [dB]	0.20	-0.09
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		86.6
Dist 3dB Peak [mm]		21.4



Measurement Report for Device, P38 LTE 2_QPSK20M_Rear Face_1cm_Ch 18700_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 2	LTE-FDD, 10169-CAF	1860.000, 18700	7.77	1.43	39.9

Hardware Setup

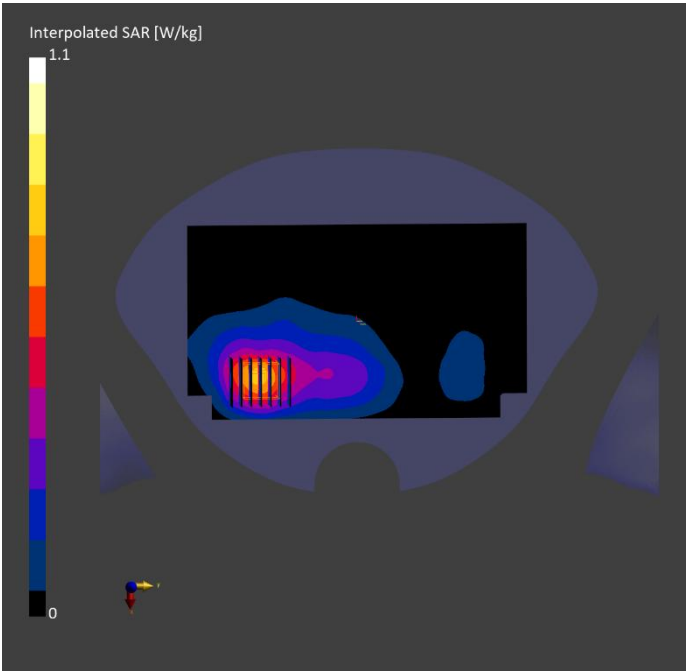
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-25	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-25	2025-02-25
psSAR1g [W/kg]	0.646	0.661
psSAR10g [W/kg]	0.377	0.388
Power Drift [dB]	-0.05	-0.05
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		84.6
Dist 3dB Peak [mm]		14.7



Measurement Report for Device, P39 LTE 4_QPSK20M_Rear Face_1cm_Ch 20050_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 4	LTE-FDD, 10169-CAF	1720.000, 20050	8.01	1.36	40.2

Hardware Setup

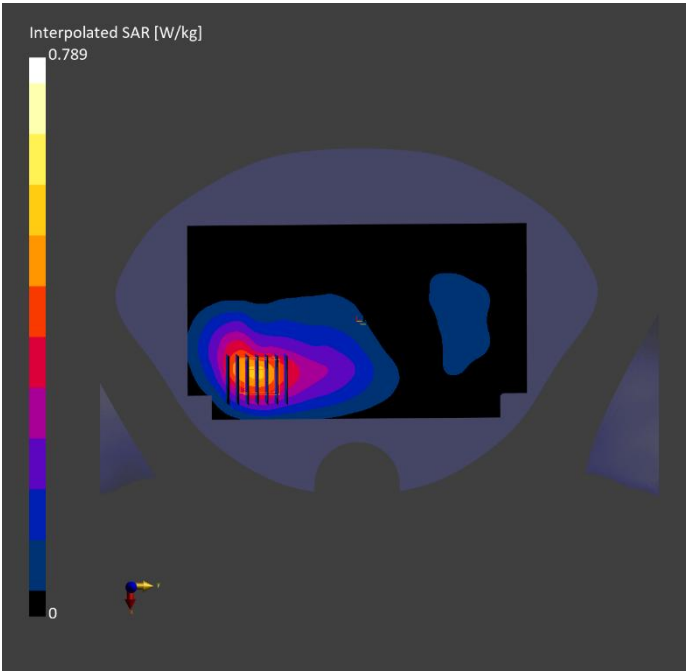
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-26	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-26	2025-02-26
psSAR1g [W/kg]	0.461	0.470
psSAR10g [W/kg]	0.275	0.286
Power Drift [dB]	0.02	-0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		83.7
Dist 3dB Peak [mm]		14.5



Measurement Report for Device, P40 LTE 5_QPSK10M_Rear Face_1cm_Ch 20525_1RB_OS24

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 5	LTE-FDD, 10175-CAH	836.500, 20525	9.7	0.943	43.2

Hardware Setup

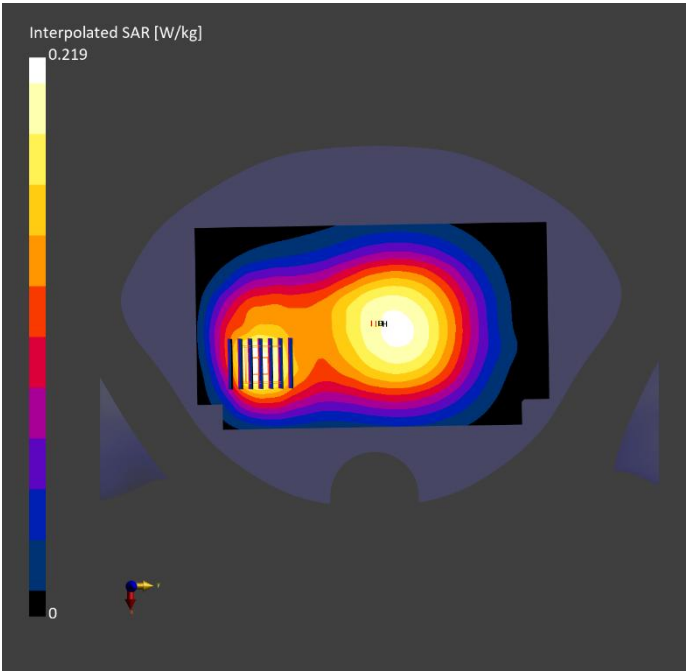
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-24	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-24	2025-02-24
psSAR1g [W/kg]	0.144	0.141
psSAR10g [W/kg]	0.097	0.091
Power Drift [dB]	-0.00	-0.03
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		88.5
Dist 3dB Peak [mm]		18.3



Measurement Report for Device, P41 LTE 12&17_QPSK10M_Right Side_1cm_Ch 23130_1RB_OS24

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	EDGE RIGHT, 10.00	Band 12	LTE-FDD, 10175-CAH	711.000, 23130	9.99	0.904	43.0

Hardware Setup

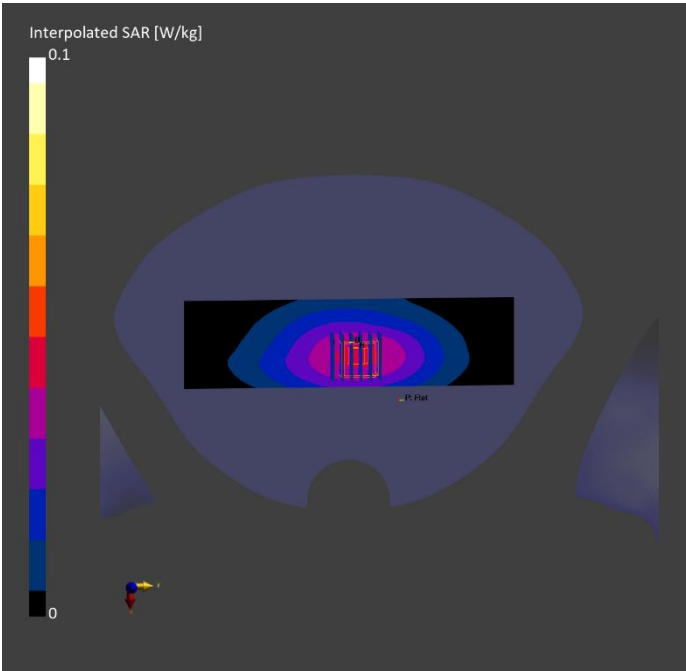
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-27	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	56.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	14.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-27	2025-02-27
psSAR1g [W/kg]	0.039	0.042
psSAR10g [W/kg]	0.027	0.030
Power Drift [dB]	-0.01	-0.00
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		90.7
Dist 3dB Peak [mm]		> 15.0



Measurement Report for Device, P42 LTE 41_QPSK20M_Rear Face_1cm_Ch 41040_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 41	LTE-TDD, 10172-CAH	2635.000, 41040	7.29	1.97	39.3

Hardware Setup

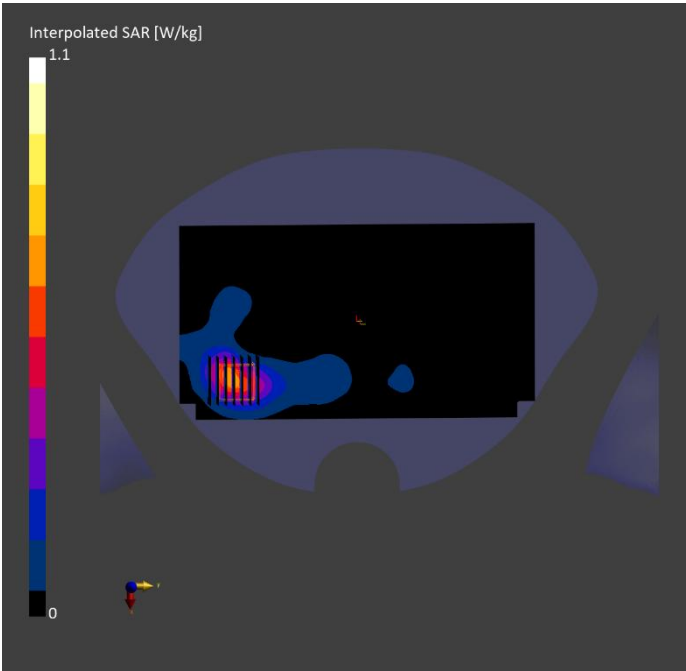
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-27	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 220.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-27	2025-02-27
psSAR1g [W/kg]	0.565	0.589
psSAR10g [W/kg]	0.272	0.289
Power Drift [dB]	-0.02	-0.02
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		82.6
Dist 3dB Peak [mm]		10.0



Measurement Report for Device, P43 LTE 66_QPSK20M_Rear Face_1cm_Ch 132072_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 66	LTE-FDD, 10169-CAF	1720.000, 132072	8.01	1.36	40.2

Hardware Setup

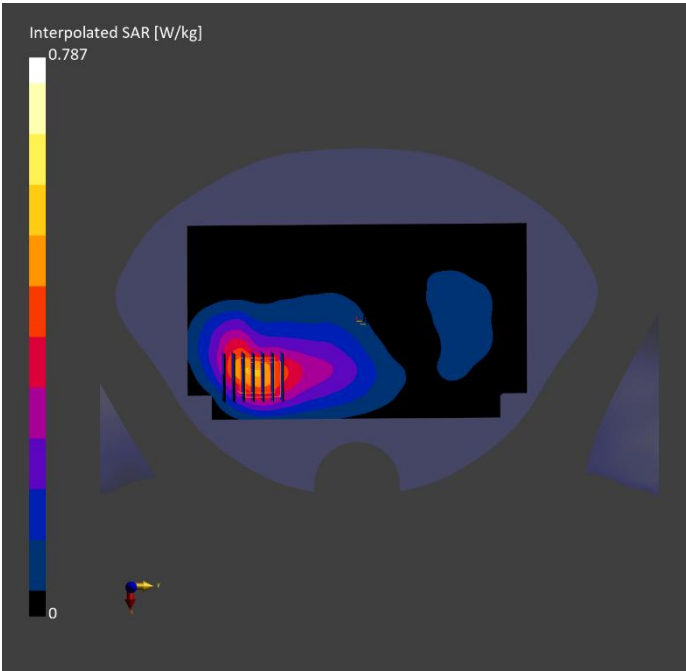
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-26	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-26	2025-02-26
psSAR1g [W/kg]	0.452	0.471
psSAR10g [W/kg]	0.271	0.288
Power Drift [dB]	-0.07	0.01
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		84.9
Dist 3dB Peak [mm]		13.5



Measurement Report for Device, P44 LTE 71_QPSK20M_Rear Face_1cm_Ch 133222_1RB_OS50

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	Band 71	LTE-FDD, 10169-CAF	673.000, 133222	9.99	0.891	43.1

Hardware Setup

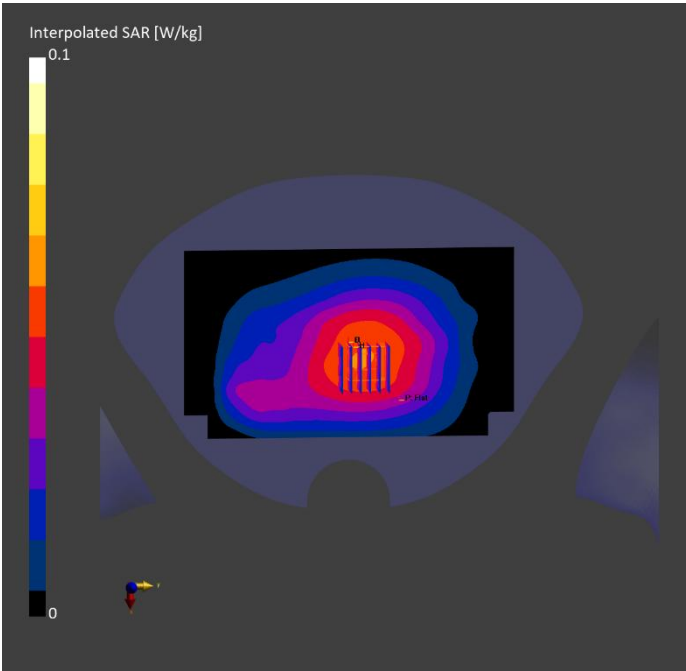
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-27	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 210.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	15.0 x 15.0	6.0 x 6.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-27	2025-02-27
psSAR1g [W/kg]	0.052	0.054
psSAR10g [W/kg]	0.038	0.044
Power Drift [dB]	-0.01	-0.05
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		97.2
Dist 3dB Peak [mm]		> 15.0



Measurement Report for Device, P45 802.11b_Right Side_1cm_Ch 6

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	EDGE RIGHT, 10.00	WLAN 2.4GHz	WLAN, 10415-AAA	2437.000, 6	7.25	1.82	39.6

Hardware Setup

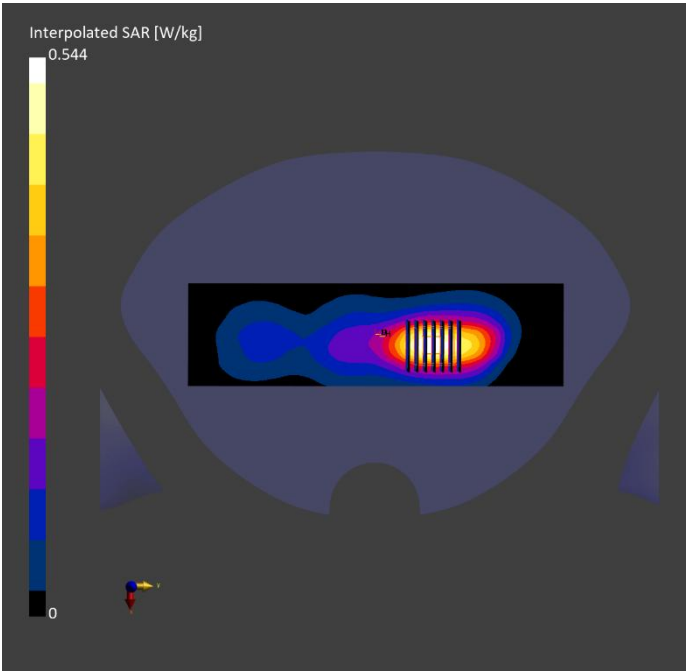
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-28	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	60.0 x 220.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	N/A	N/A
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-28	2025-02-28
psSAR1g [W/kg]	0.303	0.316
psSAR10g [W/kg]	0.161	0.175
Power Drift [dB]	0.08	-0.04
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		84.1
Dist 3dB Peak [mm]		12.0



Measurement Report for Device, P46 802.11a_Rear Face_1cm_Ch 48

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	BACK, 10.00	U-NII-1, U-NII-2A	WLAN, 10417-AAD	5240.000, 48	5.45	4.62	37.1

Hardware Setup

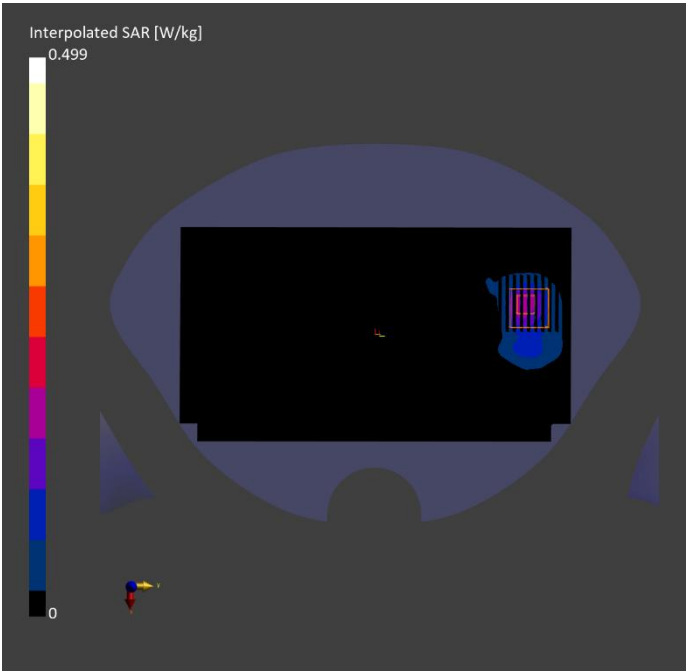
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-28	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	120.0 x 220.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-28	2025-02-28
psSAR1g [W/kg]	0.147	0.140
psSAR10g [W/kg]	0.055	0.044
Power Drift [dB]	0.00	-0.05
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		68.4
Dist 3dB Peak [mm]		7.9



Measurement Report for Device, P47 802.11a_Right Side_1cm_Ch 157

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	EDGE RIGHT, 10.00	U-NII-2C, U-NII-3	WLAN, 10317-AAE	5785.000, 157	4.98	5.22	36.1

Hardware Setup

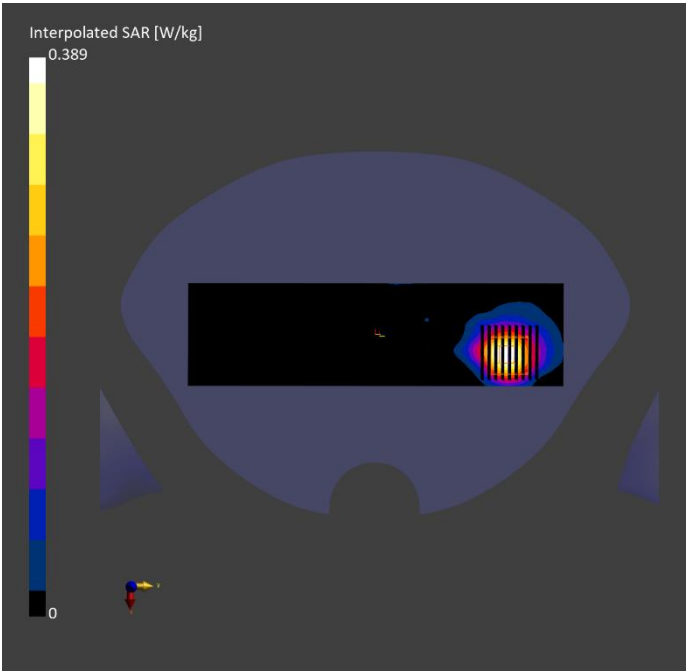
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-28	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	60.0 x 220.0	22.0 x 22.0 x 22.0
Grid Steps [mm]	10.0 x 10.0	4.0 x 4.0 x 1.4
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.4
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-28	2025-02-28
psSAR1g [W/kg]	0.111	0.099
psSAR10g [W/kg]	0.043	0.034
Power Drift [dB]	0.00	-0.07
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		63.7
Dist 3dB Peak [mm]		9.4



Measurement Report for Device, P48 BT_Right Side_1cm_Ch 78

Device under Test Properties

Model, Manufacturer	Dimensions [mm]	IMEI	DUT Type
Device,	175.0 x 84.0 x 14.0		Mobile Phone

Exposure Conditions

Phantom Section, TSL	Position, Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat, HSL	EDGE RIGHT, 10.00	ISM 2.4 GHz Band	Bluetooth, 10032-CAA	2480.000, 78	7.25	1.86	39.5

Hardware Setup

Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
Twin-SAM V8.0 (30deg probe tilt) - 2097	HSL600-10000, 2025-Feb-28	EX3DV4 - SN7628, 2024-07-03	DAE4 Sn1557, 2024-10-08

Scan Setup

	Area Scan	Zoom Scan
Grid Extents [mm]	60.0 x 220.0	30.0 x 30.0 x 30.0
Grid Steps [mm]	10.0 x 10.0	5.0 x 5.0 x 1.5
Sensor Surface [mm]	3.0	1.4
Graded Grid	N/A	Yes
Grading Ratio	N/A	1.5
MAIA	Y	Y
Surface Detection	VMS + 6p	VMS + 6p
Scan Method	Measured	Measured

Measurement Results

	Area Scan	Zoom Scan
Date	2025-02-28	2025-02-28
psSAR1g [W/kg]	0.036	0.036
psSAR10g [W/kg]	0.018	0.019
Power Drift [dB]	-0.15	-0.04
Power Scaling	Disabled	Disabled
Scaling Factor [dB]		
TSL Correction	No correction	No correction
M2/M1 [%]		88.1
Dist 3dB Peak [mm]		9.9

